

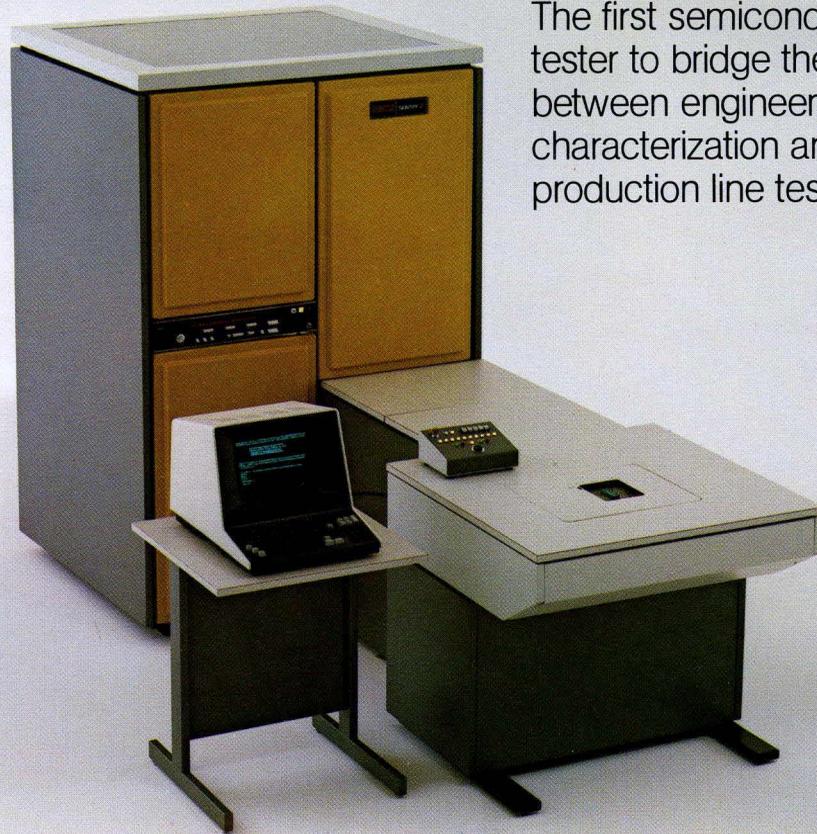
**TO SEE WHAT  
WE'RE GOING  
TO DO NEXT**

**SEE WHAT WE'VE ALREADY DONE FIRST**

**FAIRCHILD**

# SENTRY<sup>®</sup>V

The first semiconductor tester to bridge the gap between engineering characterization and production line testing.



# SENTRY VII

The first random logic LSI test system and the first to handle 16 bit microprocessors.



# SENTRY VIII



The first true 120-pin  
system for LSI and VLSI  
devices.

# XINCOM III

The first dedicated memory test system  
based on distributed architecture to handle  
dynamic MOS, bipolar *and* CCD devices.

